



BSI Standards Publication

Semiconductor devices – Flexible and stretchable semiconductor devices

Part 1: Bending test method for conductive thin films on flexible substrates

National foreword

This British Standard is the UK implementation of IEC 62951-1:2017.

The UK participation in its preparation was entrusted to Technical Committee EPL/47, Semiconductors.

A list of organizations represented on this committee can be obtained on request to its secretary.

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Published by BSI Standards Limited 2018

ISBN 978 0 580 89312 4

ICS 31.080.99

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This British Standard was published under the authority of the Standards Policy and Strategy Committee on 31 May 2018.

Amendments/corrigenda issued since publication

Date	Text affected
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